

<b>Notice of References Cited</b>	Application/Control No. 10/533,191	Applicant(s)/Patent Under Reexamination ANNIC, ETIENNE	
	Examiner Stephen M. D'Agosta	Art Unit 2617	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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